



Welcome to E-XFL.COM

What is "[Embedded - Microcontrollers](#)"?

"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "[Embedded - Microcontrollers](#)"

Details

Product Status	Active
Core Processor	e200z2, e200z4
Core Size	32-Bit Dual-Core
Speed	80MHz/160MHz
Connectivity	CANbus, Ethernet, I ² C, LINbus, SAI, SPI, USB, USB OTG
Peripherals	DMA, LVD, POR, WDT
Number of I/O	129
Program Memory Size	3MB (3M x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	512K x 8
Voltage - Supply (Vcc/Vdd)	3V ~ 5.5V
Data Converters	A/D 80x10b, 64x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 125°C (TA)
Mounting Type	Surface Mount
Package / Case	176-LQFP Exposed Pad
Supplier Device Package	176-LQFP (24x24)
Purchase URL	https://www.e-xfl.com/pro/item?MUrl=&PartUrl=spc5746ck1mku2

- Debug functionality
 - e200z2 core: NDI per IEEE-ISTO 5001-2008 Class3+
 - e200z4 core: NDI per IEEE-ISTO 5001-2008 Class 3+
- Timer
 - 16 Periodic Interrupt Timers (PITs)
 - Two System Timer Modules (STM)
 - Three Software Watchdog Timers (SWT)
 - 64 Configurable Enhanced Modular Input Output Subsystem (eMIOS) channels
- Device/board boundary Scan testing supported with Joint Test Action Group (JTAG) of IEEE 1149.1 and IEEE 1149.7 (CJTAG)
- Security
 - Hardware Security Module (HSMv2)
 - Password and Device Security (PASS) supporting advanced censorship and life-cycle management
 - One Fault Collection and Control Unit (FCCU) to collect faults and issue interrupts
- Functional Safety
 - ISO26262 ASIL-B compliance
- Multiple operating modes
 - Includes enhanced low power operation

Table of Contents

1	Block diagram.....	4	6.3.2	Flash memory Array Integrity and Margin Read specifications.....	39
2	Family comparison.....	4	6.3.3	Flash memory module life specifications.....	40
3	Ordering parts.....	8	6.3.4	Data retention vs program/erase cycles.....	40
3.1	Determining valid orderable parts	8	6.3.5	Flash memory AC timing specifications.....	41
3.2	Ordering Information	9	6.3.6	Flash read wait state and address pipeline control settings	42
4	General.....	9	6.4	Communication interfaces.....	43
4.1	Absolute maximum ratings.....	9	6.4.1	DSPI timing.....	43
4.2	Recommended operating conditions.....	11	6.4.2	FlexRay electrical specifications.....	49
4.3	Voltage regulator electrical characteristics.....	13	6.4.2.1	FlexRay timing.....	49
4.4	Voltage monitor electrical characteristics.....	17	6.4.2.2	TxEN.....	49
4.5	Supply current characteristics.....	18	6.4.2.3	TxD.....	50
4.6	Electrostatic discharge (ESD) characteristics.....	22	6.4.2.4	RxD.....	51
4.7	Electromagnetic Compatibility (EMC) specifications.....	23	6.4.3	Ethernet switching specifications.....	52
5	I/O parameters.....	23	6.4.4	SAI electrical specifications	53
5.1	AC specifications @ 3.3 V Range.....	23	6.5	Debug specifications.....	55
5.2	DC electrical specifications @ 3.3V Range.....	24	6.5.1	JTAG interface timing	55
5.3	AC specifications @ 5 V Range.....	25	6.5.2	Nexus timing.....	58
5.4	DC electrical specifications @ 5 V Range.....	25	6.5.3	WKPU/NMI timing.....	60
5.5	Reset pad electrical characteristics.....	26	6.5.4	External interrupt timing (IRQ pin).....	61
5.6	PORST electrical specifications.....	28	7	Thermal attributes.....	61
6	Peripheral operating requirements and behaviours.....	28	7.1	Thermal attributes.....	61
6.1	Analog.....	28	8	Dimensions.....	65
6.1.1	ADC electrical specifications.....	28	8.1	Obtaining package dimensions	65
6.1.2	Analog Comparator (CMP) electrical specifications.....	33	9	Pinouts.....	66
6.2	Clocks and PLL interfaces modules.....	34	9.1	Package pinouts and signal descriptions.....	66
6.2.1	Main oscillator electrical characteristics.....	34	10	Reset sequence.....	66
6.2.2	32 kHz Oscillator electrical specifications	36	10.1	Reset sequence.....	66
6.2.3	16 MHz RC Oscillator electrical specifications.....	36	10.1.1	Reset sequence duration.....	66
6.2.4	128 KHz Internal RC oscillator Electrical specifications	37	10.1.2	BAF execution duration.....	66
6.2.5	PLL electrical specifications	37	10.1.3	Reset sequence description.....	67
6.3	Memory interfaces.....	38	11	Revision History.....	69
6.3.1	Flash memory program and erase specifications.....	38	11.1	Revision History.....	69

Table 4. MPC5746C Family Comparison - RAM Memory Map (continued)

Start Address	End Address	Allocated size	Description	MPC5744	MPC5745	MPC5746
0x40030000	0x4003FFFF	64 KB	SRAM4	not available	available	available
0x40040000	0x4004FFFF	64 KB	SRAM5	not available	not available	available
0x40050000	0x4005FFFF	64 KB	SRAM6	not available	not available	available
0x40060000	0x4006FFFF	64 KB	SRAM7	not available	not available	optional
0x40070000	0x4007FFFF	64 KB	SRAM8	not available	not available	optional

3 Ordering parts

3.1 Determining valid orderable parts

To determine the orderable part numbers for this device, go to www.nxp.com and perform a part number search for the following device number: MPC5746C.

3.2 Ordering Information

Example Code	P	PC	57	4	6	C	S	K0	M	MJ	6	R
Qualification Status	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____
Power Architecture	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____
Automotive Platform	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____
Core Version	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____
Flash Size (core dependent)	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____
Product	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____
Optional fields	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____
Fab and mask indicator	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____
Temperature spec.	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____
Package Code	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____
CPU Frequency	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____	_____
R = Tape & Reel (blank if Tray)												

Qualification Status P = Engineering samples S = Automotive qualified PC = Power Architecture Automotive Platform 57 = Power Architecture in 55nm Core Version 4 = e200z4 Core Version (highest core version in the case of multiple cores) Flash Memory Size 4 = 1.5 MB 5 = 2 MB 6 = 3 MB	Product Version B = Single core C = Dual core Optional fields Blank = No optional feature S = HSM (Security Module) F = CAN FD B = HSM + CAN FD R = 512K RAM T = HSM + 512K RAM G* = CAN FD + 512K RAM H* = HSM + CAN FD + 512K RAM * G and H for 5746 B/C only	Fab and mask version indicator K = TSMC Fab #(0,1,etc.) = Version of the maskset, like rev. 0=0N65H Temperature spec. C = -40.C to +85.C Ta V = -40.C to +105.C Ta M = -40.C to +125.C Ta	Package Code KU = 176 LQFP EP MJ = 256 MAPBGA MN = 324 MAPBGA MH = 100MAPBGA CPU Frequency 2 = Z4 operates upto 120 MHz 6 = Z4 operates upto 160 MHz Shipping Method R = Tape and reel Blank = Tray
--	--	---	--

Note: Not all part number combinations are available as production product

4 General

4.1 Absolute maximum ratings

NOTE

Functional operating conditions appear in the DC electrical characteristics. Absolute maximum ratings are stress ratings only, and functional operation at the maximum values is not guaranteed. See footnotes in [Table 5](#) for specific conditions

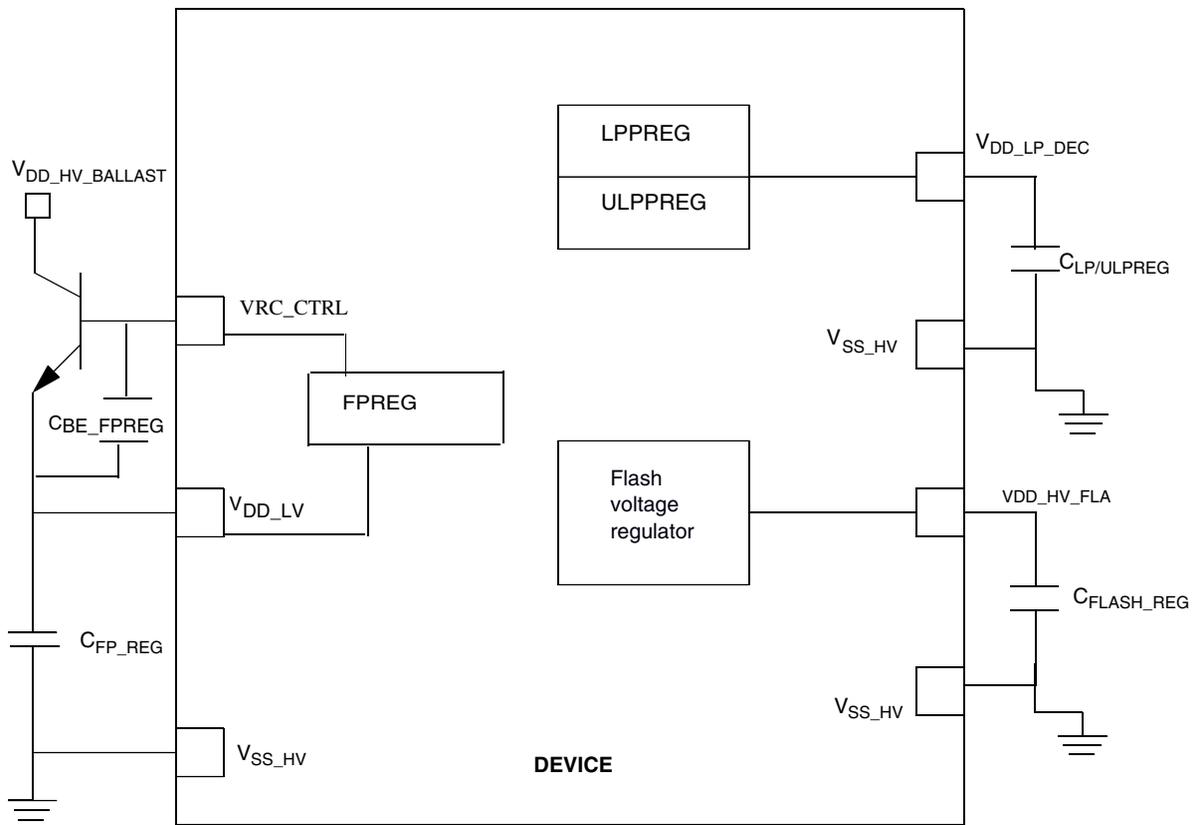


Figure 2. Voltage regulator capacitance connection

NOTE

On BGA, VSS_LV and VSS_HV have been joined on substrate and renamed as VSS.

Table 8. Voltage regulator electrical specifications

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
C _{fp_reg} ¹	External decoupling / stability capacitor	Min, max values shall be granted with respect to tolerance, voltage, temperature, and aging variations.	1.32	2.2 ²	3	μF
	Combined ESR of external capacitor	—	0.001	—	0.03	Ohm
C _{lp/ulp_reg}	External decoupling / stability capacitor for internal low power regulators	Min, max values shall be granted with respect to tolerance, voltage, temperature, and aging variations.	0.8	1	1.4	μF
	Combined ESR of external capacitor	—	0.001	—	0.1	Ohm
C _{be_fpreg} ³	Capacitor in parallel to base-emitter	BCP68 and BCP56		3.3		nF
		MJD31		4.7		

Table continues on the next page...

Table 10. Current consumption characteristics (continued)

Symbol	Parameter	Conditions ¹	Min	Typ	Max	Unit
I _{DD_BODY_2} 6	RUN Body Mode Profile Operating current	LV supply + HV supply + HV Flash supply + 2 x HV ADC supplies ⁴ T _a = 125°C ⁵ V _{DD_LV} = 1.25 V VDD_HV_A = 5.5V SYS_CLK = 160MHz	—	—	246	mA
		T _a = 105°C	—	—	235	mA
		T _a = 85°C	—	—	210	mA
I _{DD_BODY_3} 7	RUN Body Mode Profile Operating current	LV supply + HV supply + HV Flash supply + 2 x HV ADC supplies ⁴ T _a = 125 °C ⁵ V _{DD_LV} = 1.25 V VDD_HV_A = 5.5V SYS_CLK = 120MHz	—	—	181	mA
		T _a = 105 °C	—	—	176	mA
		T _a = 85°C	—	—	171	mA
I _{DD_BODY_4} ⁸	RUN Body Mode Profile Operating current	LV supply + HV supply + HV Flash supply + 2 x HV ADC supplies ⁴ T _a = 125 °C ⁵ V _{DD_LV} = 1.25 V VDD_HV_A = 5.5V SYS_CLK = 120MHz	—	—	264	mA
		T _a = 105 °C	—	—	176	mA
		T _a = 85 °C	—	—	171	mA
I _{DD_STOP}	STOP mode Operating current	T _a = 125 °C ⁹ V _{DD_LV} = 1.25 V	—	—	49	mA
		T _a = 105 °C V _{DD_LV} = 1.25 V	—	10.6	—	
		T _a = 85 °C V _{DD_LV} = 1.25 V	—	8.1	—	
		T _a = 25 °C V _{DD_LV} = 1.25 V	—	4.6	—	

Table continues on the next page...

5.2 DC electrical specifications @ 3.3V Range

Table 15. DC electrical specifications @ 3.3V Range

Symbol	Parameter	Value		Unit
		Min	Max	
Vih (pad_i_hv)	Pad_I_HV Input Buffer High Voltage	$0.72 * VDD_HV_x$	$VDD_HV_x + 0.3$	V
Vil (pad_i_hv)	Pad_I_HV Input Buffer Low Voltage	$VDD_HV_x - 0.3$	$0.45 * VDD_HV_x$	V
Vhys (pad_i_hv)	Pad_I_HV Input Buffer Hysteresis	$0.11 * VDD_HV_x$		V
Vih_hys	CMOS Input Buffer High Voltage (with hysteresis enabled)	$0.67 * VDD_HV_x$	$VDD_HV_x + 0.3$	V
Vil_hys	CMOS Input Buffer Low Voltage (with hysteresis enabled)	$VDD_HV_x - 0.3$	$0.35 * VDD_HV_x$	V
Vih	CMOS Input Buffer High Voltage (with hysteresis disabled)	$0.57 * VDD_HV_x^{1,1}$	$VDD_HV_x^{1,1} + 0.3$	V
Vil	CMOS Input Buffer Low Voltage (with hysteresis disabled)	$VDD_HV_x - 0.3$	$0.4 * VDD_HV_x^{1,1}$	V
Vhys	CMOS Input Buffer Hysteresis	$0.09 * VDD_HV_x^{1,1}$		V
Pull_IH (pad_i_hv)	Weak Pullup Current ^{2,2} Low	15		μA
Pull_IH (pad_i_hv)	Weak Pullup Current ^{3,3} High		55	μA
Pull_IL (pad_i_hv)	Weak Pulldown Current ³ Low	28		μA
Pull_IL (pad_i_hv)	Weak Pulldown Current ² High		85	μA
Pull_loh	Weak Pullup Current ⁴	15	50	μA
Pull_lol	Weak Pulldown Current ⁵	15	50	μA
linact_d	Digital Pad Input Leakage Current (weak pull inactive)	-2.5	2.5	μA
Voh	Output High Voltage ⁶	$0.8 * VDD_HV_x^{1,1}$	—	V
Vol	Output Low Voltage ⁷ Output Low Voltage ⁸	—	$0.2 * VDD_HV_x^{1,1}$ $0.1 * VDD_HV_x$	V
Ioh_f	Full drive Ioh ^{9,9} (SIUL2_MSCRn.SRC[1:0] = 11)	18	70	mA
Iol_f	Full drive Iol ⁹ (SIUL2_MSCRn.SRC[1:0] = 11)	21	120	mA
Ioh_h	Half drive Ioh ⁹ (SIUL2_MSCRn.SRC[1:0] = 10)	9	35	mA
Iol_h	Half drive Iol ⁹ (SIUL2_MSCRn.SRC[1:0] = 10)	10.5	60	mA

1. $VDD_HV_x = VDD_HV_A, VDD_HV_B, VDD_HV_C$
2. Measured when $pad = 0.69 * VDD_HV_x$
3. Measured when $pad = 0.49 * VDD_HV_x$
4. Measured when $pad = 0 V$
5. Measured when $pad = VDD_HV_x$
6. Measured when pad is sourcing 2 mA
7. Measured when pad is sinking 2 mA
8. Measured when pad is sinking 1.5 mA
9. Ioh/Iol is derived from spice simulations. These values are NOT guaranteed by test.

Table 18. Functional reset pad electrical specifications (continued)

Symbol	Parameter	Conditions	Value			Unit
			Min	Typ	Max	
V _{HYS}	CMOS Input Buffer hysteresis	—	300	—	—	mV
V _{DD_POR}	Minimum supply for strong pull-down activation	—	—	—	1.2	V
I _{OL_R}	Strong pull-down current ^{1, 1}	Device under power-on reset V _{DD_HV_A} = V _{DD_POR} V _{OL} = 0.35 × V _{DD_HV_A}	0.2	—	—	mA
		Device under power-on reset V _{DD_HV_A} = V _{DD_POR} V _{OL} = 0.35 × V _{DD_HV_IO}	11	—	—	mA
W _{FRST}	RESET input filtered pulse	—	—	—	500	ns
W _{NFRST}	RESET input not filtered pulse	—	2000	—	—	ns
I _{WPU}	Weak pull-up current absolute value	RESET pin V _{IN} = V _{DD}	23	—	82	μA

1. Strong pull-down is active on PHASE0, PHASE1, PHASE2, and the beginning of PHASE3 for RESET.

5.6 PORST electrical specifications

Table 19. PORST electrical specifications

Symbol	Parameter	Value			Unit
		Min	Typ	Max	
W _{F_{PORST}}	PORST input filtered pulse	—	—	200	ns
W _{N_{F_{PORST}}}	PORST input not filtered pulse	1000	—	—	ns
V _{IH}	Input high level	0.65 × V _{DD_HV_A}	—	—	V
V _{IL}	Input low level	—	—	0.35 × V _{DD_HV_A}	V

6 Peripheral operating requirements and behaviours

6.1 Analog

6.1.1 ADC electrical specifications

The device provides a 12-bit Successive Approximation Register (SAR) Analog-to-Digital Converter.

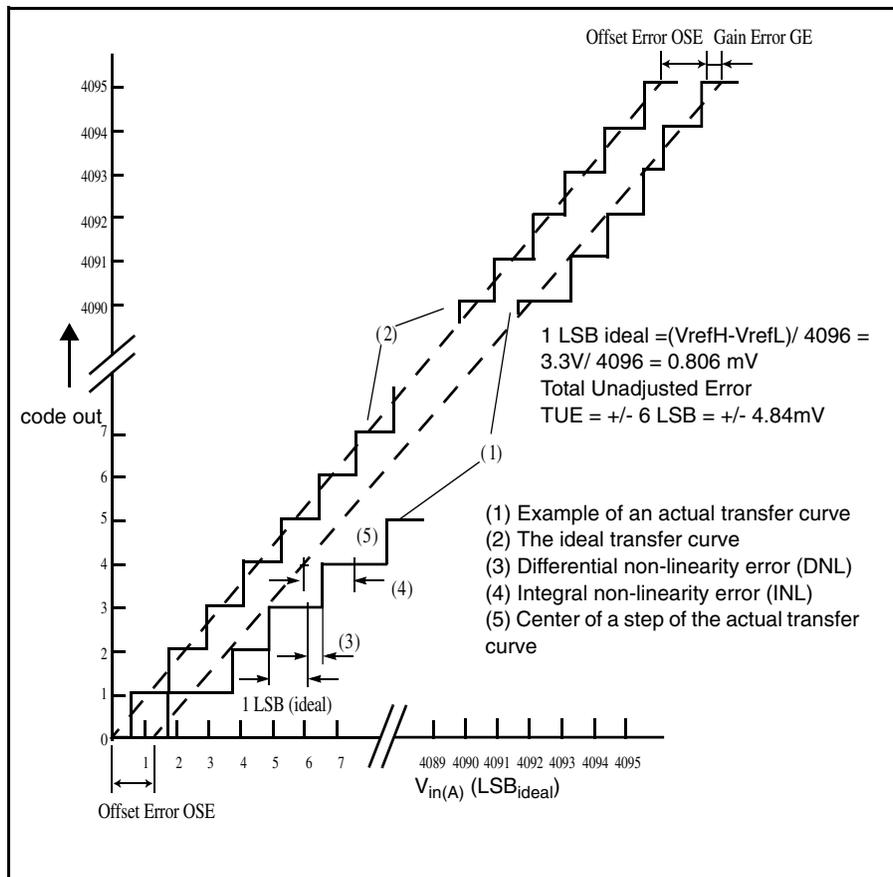


Figure 5. ADC characteristics and error definitions

6.1.2 Analog Comparator (CMP) electrical specifications

Table 22. Comparator and 6-bit DAC electrical specifications

Symbol	Description	Min.	Typ.	Max.	Unit
I_{DDHS}	Supply current, High-speed mode (EN=1, PMODE=1)	—	—	250	μA
$I_{DDL S}$	Supply current, low-speed mode (EN=1, PMODE=0)	—	5	11	μA
V_{AIN}	Analog input voltage	V_{SS}	—	$V_{IN1_CMP_REF}$	V
V_{AIO}	Analog input offset voltage ^{1, 1}	-47	—	47	mV
V_H	Analog comparator hysteresis ^{2, 2} <ul style="list-style-type: none"> • CR0[HYSTCTR] = 00 • CR0[HYSTCTR] = 01 • CR0[HYSTCTR] = 10 • CR0[HYSTCTR] = 11 	—	1	25	mV
		—	20	50	mV
		—	40	70	mV
		—	60	105	mV
		—	—	—	—
t_{DHS}	Propagation Delay, High Speed Mode (Full Swing) ^{1, 3, 3}	—	—	250	ns
t_{DLS}	Propagation Delay, Low power Mode (Full Swing) ^{1, 3}	—	5	21	μs
	Analog comparator initialization delay, High speed mode ^{4, 4}	—	4		μs
	Analog comparator initialization delay, Low speed mode ⁴	—	100		μs
I_{DAC6b}	6-bit DAC current adder (when enabled)				
	3.3V Reference Voltage	—	6	9	μA
	5V Reference Voltage	—	10	16	μA
INL	6-bit DAC integral non-linearity	-0.5	—	0.5	LSB ⁵
DNL	6-bit DAC differential non-linearity	-0.8	—	0.8	LSB

1. Measured with hysteresis mode of 00
2. Typical hysteresis is measured with input voltage range limited to 0.6 to $V_{DD_HV_A}-0.6\text{V}$
3. Full swing = V_{IH} , V_{IL}
4. Comparator initialization delay is defined as the time between software writes to change control inputs (Writes to DACEN, VRSEL, PSEL, MSEL, VOSEL) and the comparator output settling to a stable level.
5. 1 LSB = $V_{reference}/64$

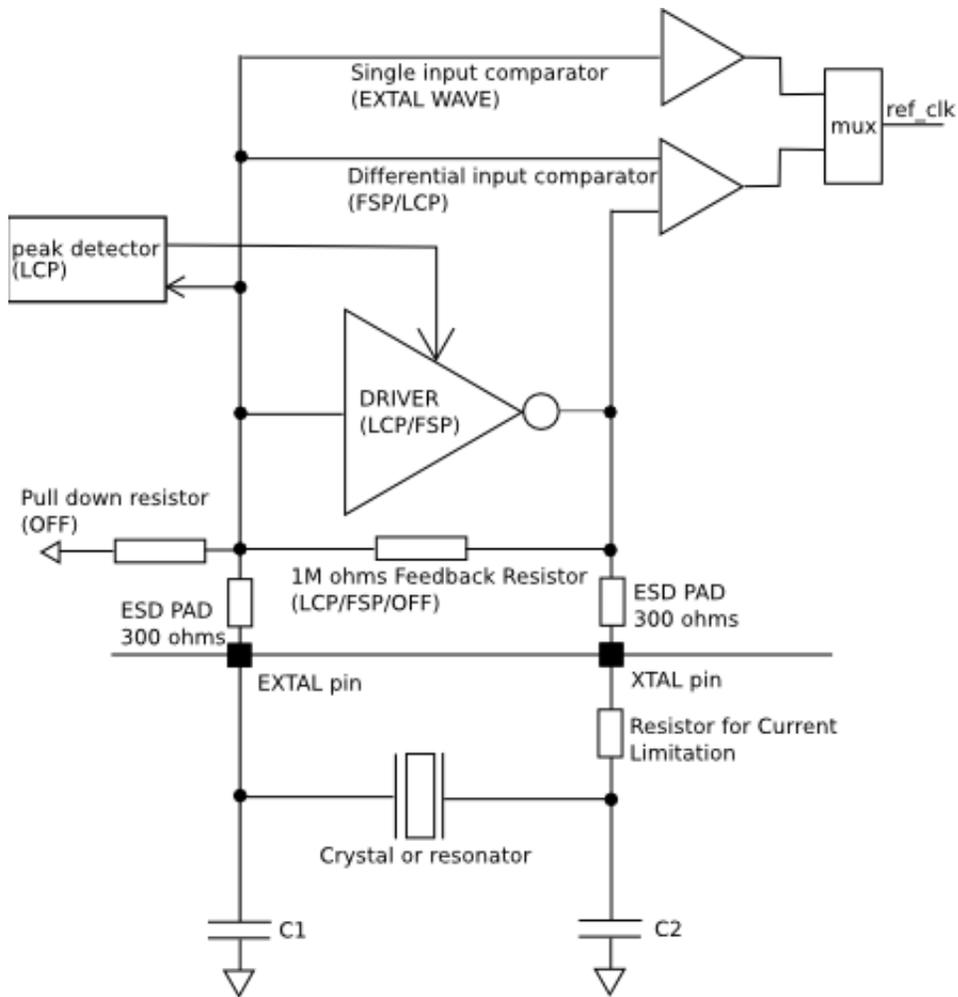


Figure 7. Oscillator connections scheme

Table 23. Main oscillator electrical characteristics

Symbol	Parameter	Mode	Conditions	Min	Typ	Max	Unit
f_{XOSCHS}	Oscillator frequency	FSP/LCP		8		40	MHz
$g_{mXOSCHS}$	Driver Transconductance	LCP			23		mA/V
		FSP			33		
V_{XOSCHS}	Oscillation Amplitude	LCP ^{1, 2, 1, 2}	8 MHz		1.0		V_{PP}
			16 MHz		1.0		
			40 MHz		0.8		
$T_{XOSCHSSU}$	Startup time	FSP/LCP ¹	8 MHz		2		ms
			16 MHz		1		
			40 MHz		0.5		

Table continues on the next page...

Table 35. DSPI electrical specifications (continued)

No	Symbol	Parameter	Conditions	High Speed Mode		low Speed mode		Unit
				Min	Max	Min	Max	
12	t_{HO}	Data hold time for outputs	Master (MTFE = 0)	NA	—	-2	—	ns
			Slave	4	—	6	—	
			Master (MTFE = 1, CPHA = 0)	-2	—	10 ¹	—	
			Master (MTFE = 1, CPHA = 1)	-2	—	-2	—	

1. SMPL_PTR should be set to 1

NOTE

Restriction For High Speed modes

- DSPI2, DSPI3, SPI1 and SPI2 will support 40MHz Master mode SCK
- DSPI2, DSPI3, SPI1 and SPI2 will support 25MHz Slave SCK frequency
- Only one {SIN,SOUT and SCK} group per DSPI/SPI will support high frequency mode
- For Master mode MTFE will be 1 for high speed mode
- For high speed slaves, their master have to be in MTFE=1 mode or should be able to support 15ns tSUO delay

NOTE

For numbers shown in the following figures, see [Table 35](#)

Table 36. Continuous SCK timing

Spec	Characteristics	Pad Drive/Load	Value	
			Min	Max
tSCK	SCK cycle timing	strong/50 pF	100 ns	-
-	PCS valid after SCK	strong/50 pF	-	15 ns
-	PCS valid after SCK	strong/50 pF	-4 ns	-

Table 37. DSPI high speed mode I/Os

DSPI	High speed SCK	High speed SIN	High speed SOUT
DSPI2	GPIO[78]	GPIO[76]	GPIO[77]
DSPI3	GPIO[100]	GPIO[101]	GPIO[98]
SPI1	GPIO[173]	GPIO[175]	GPIO[176]
SPI2	GPIO[79]	GPIO[110]	GPIO[111]

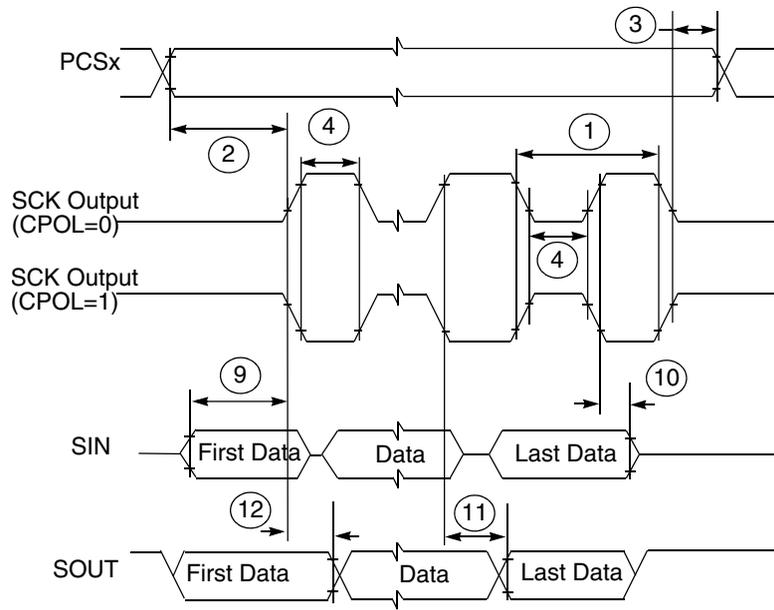


Figure 12. DSPI modified transfer format timing — master, CPHA = 0

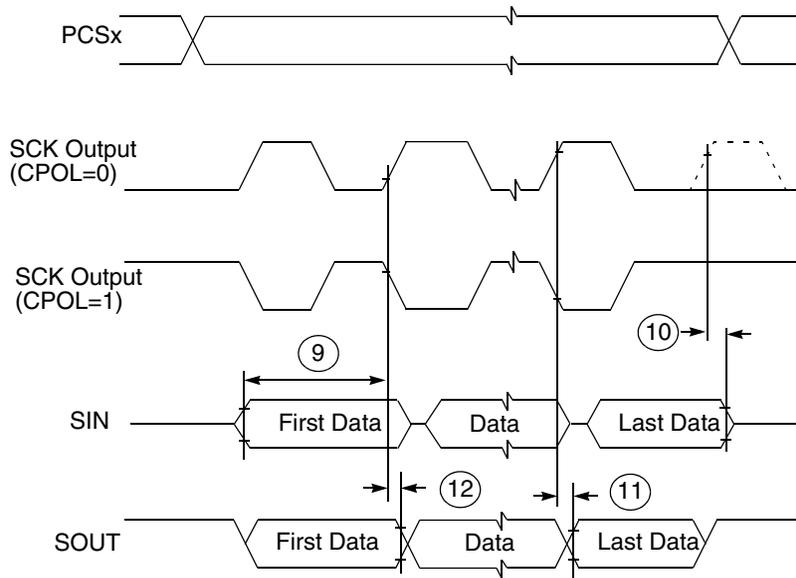


Figure 13. DSPI modified transfer format timing — master, CPHA = 1

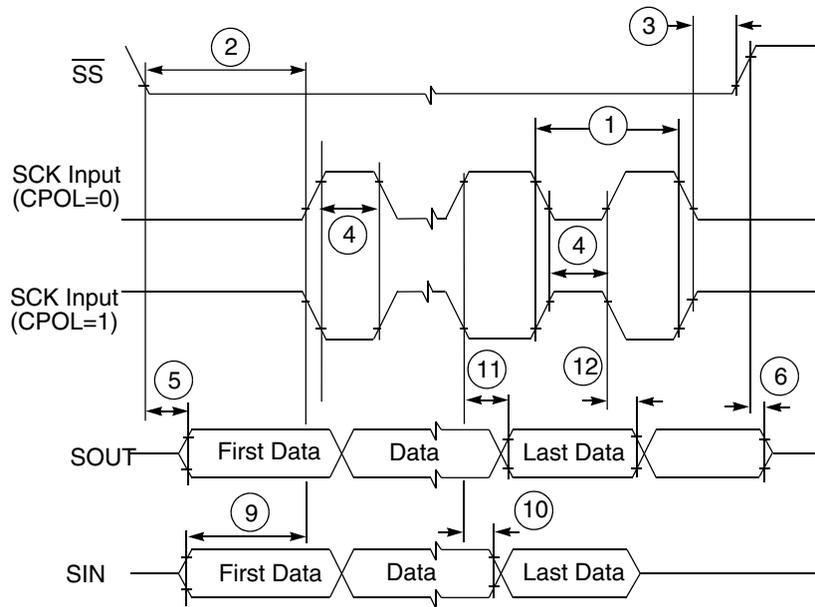


Figure 14. DSPI modified transfer format timing – slave, CPHA = 0

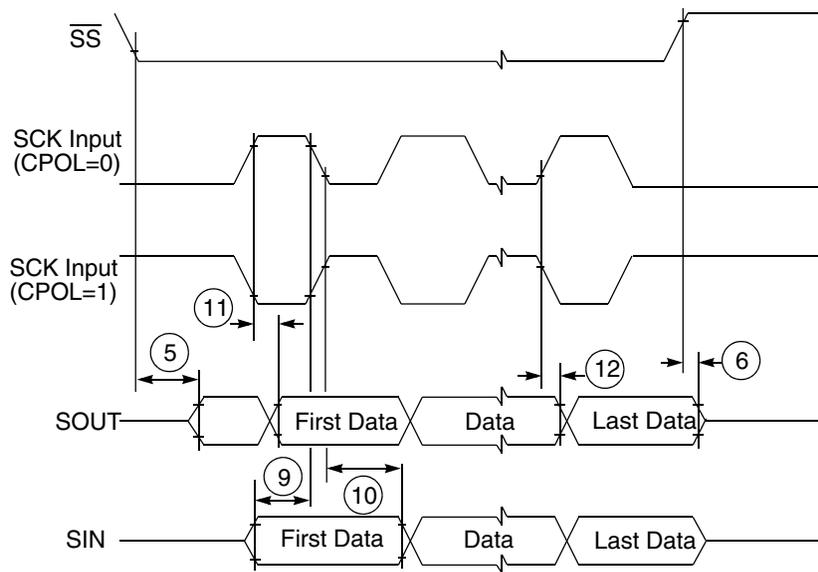


Figure 15. DSPI modified transfer format timing — slave, CPHA = 1

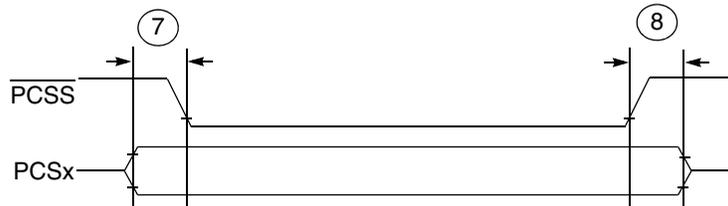


Figure 16. DSPI PCS strobe (PCSS) timing

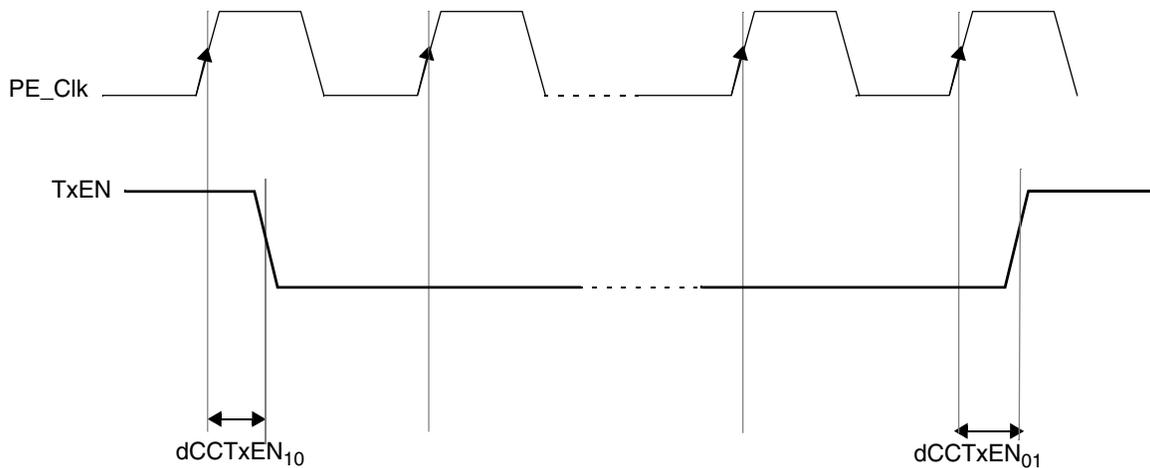


Figure 18. TxEN signal propagation delays

6.4.2.3 TxD

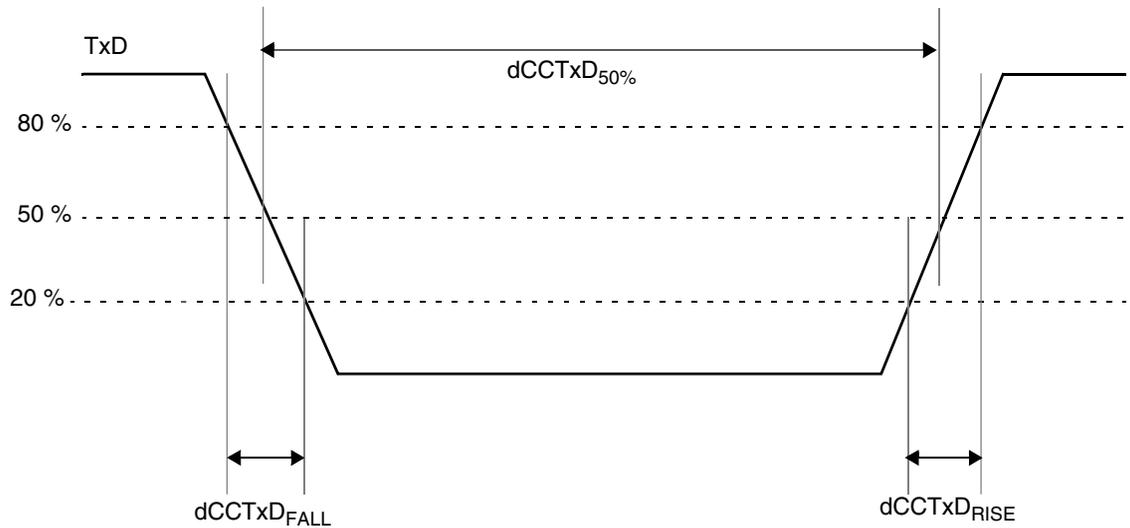


Figure 19. TxD Signal

Table 39. TxD output characteristics

Name	Description ¹	Min	Max	Unit
dCCT _{xAsym}	Asymmetry of sending CC @ 25 pF load (=dCCTxD50% - 100 ns)	-2.45	2.45	ns
dCCTxD _{RISE25} +dCCTxD _{FALL25}	Sum of Rise and Fall time of TxD signal at the output	—	9 ²	ns

Table continues on the next page...

1. All parameters specified for VDD_HV_IOx = 3.3 V -5%, ±10%, TJ = -40 oC / 150 oC.

6.4.3 Ethernet switching specifications

The following timing specs are defined at the chip I/O pin and must be translated appropriately to arrive at timing specs/constraints for the physical interface.

6.4.3.1 MII signal switching specifications

The following timing specs meet the requirements for MII style interfaces for a range of transceiver devices.

Table 41. MII signal switching specifications

Symbol	Description	Min.	Max.	Unit
—	RXCLK frequency	—	25	MHz
MII1	RXCLK pulse width high	35%	65%	RXCLK period
MII2	RXCLK pulse width low	35%	65%	RXCLK period
MII3	RXD[3:0], RXDV, RXER to RXCLK setup	5	—	ns
MII4	RXCLK to RXD[3:0], RXDV, RXER hold	5	—	ns
—	TXCLK frequency	—	25	MHz
MII5	TXCLK pulse width high	35%	65%	TXCLK period
MII6	TXCLK pulse width low	35%	65%	TXCLK period
MII7	TXCLK to TXD[3:0], TXEN, TXER invalid	2	—	ns
MII8	TXCLK to TXD[3:0], TXEN, TXER valid	—	25	ns

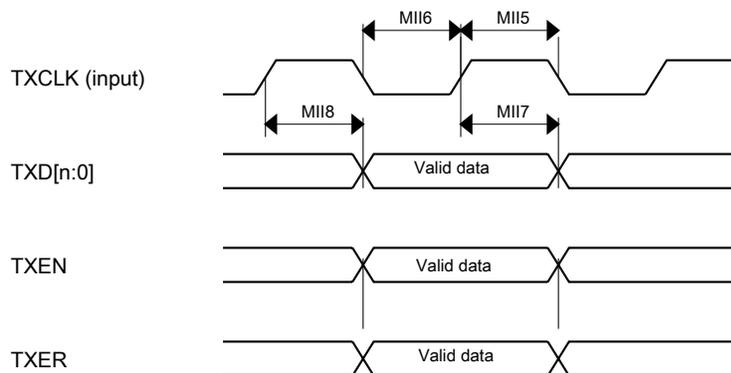


Figure 21. RMII/MII transmit signal timing diagram

Table 43. Master mode SAI Timing (continued)

no	Parameter	Value		Unit
		Min	Max	
S2	SAI_MCLK pulse width high/low	45%	55%	MCLK period
S3	SAI_BCLK cycle time	80	-	BCLK period
S4	SAI_BCLK pulse width high/low	45%	55%	ns
S5	SAI_BCLK to SAI_FS output valid	-	15	ns
S6	SAI_BCLK to SAI_FS output invalid	0	-	ns
S7	SAI_BCLK to SAI_TXD valid	-	15	ns
S8	SAI_BCLK to SAI_TXD invalid	0	-	ns
S9	SAI_RXD/SAI_FS input setup before SAI_BCLK	28	-	ns
S10	SAI_RXD/SAI_FS input hold after SAI_BCLK	0	-	ns

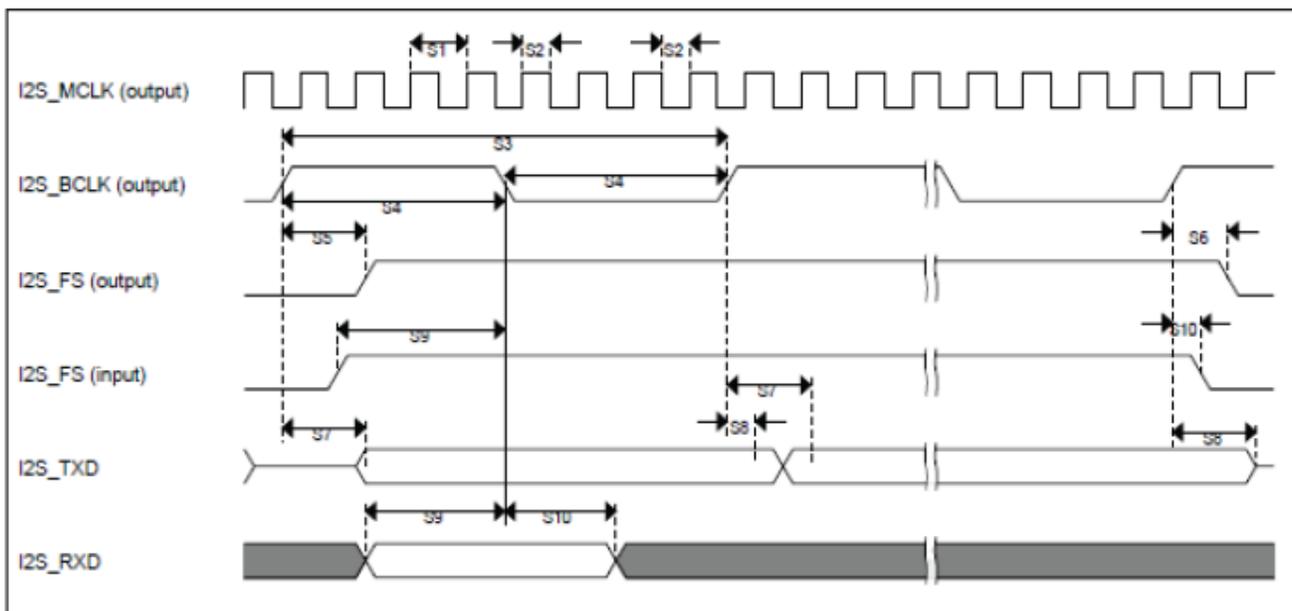


Figure 23. Master mode SAI Timing

Table 44. Slave mode SAI Timing

No	Parameter	Value		Unit
		Min	Max	
	Operating Voltage	2.7	3.6	V
S11	SAI_BCLK cycle time (input)	80	-	ns
S12	SAI_BCLK pulse width high/low (input)	45%	55%	BCLK period
S13	SAI_FS input setup before SAI_BCLK	10	-	ns
S14	SAI_FS input hold after SAI_BCLK	2	-	ns

Table continues on the next page...

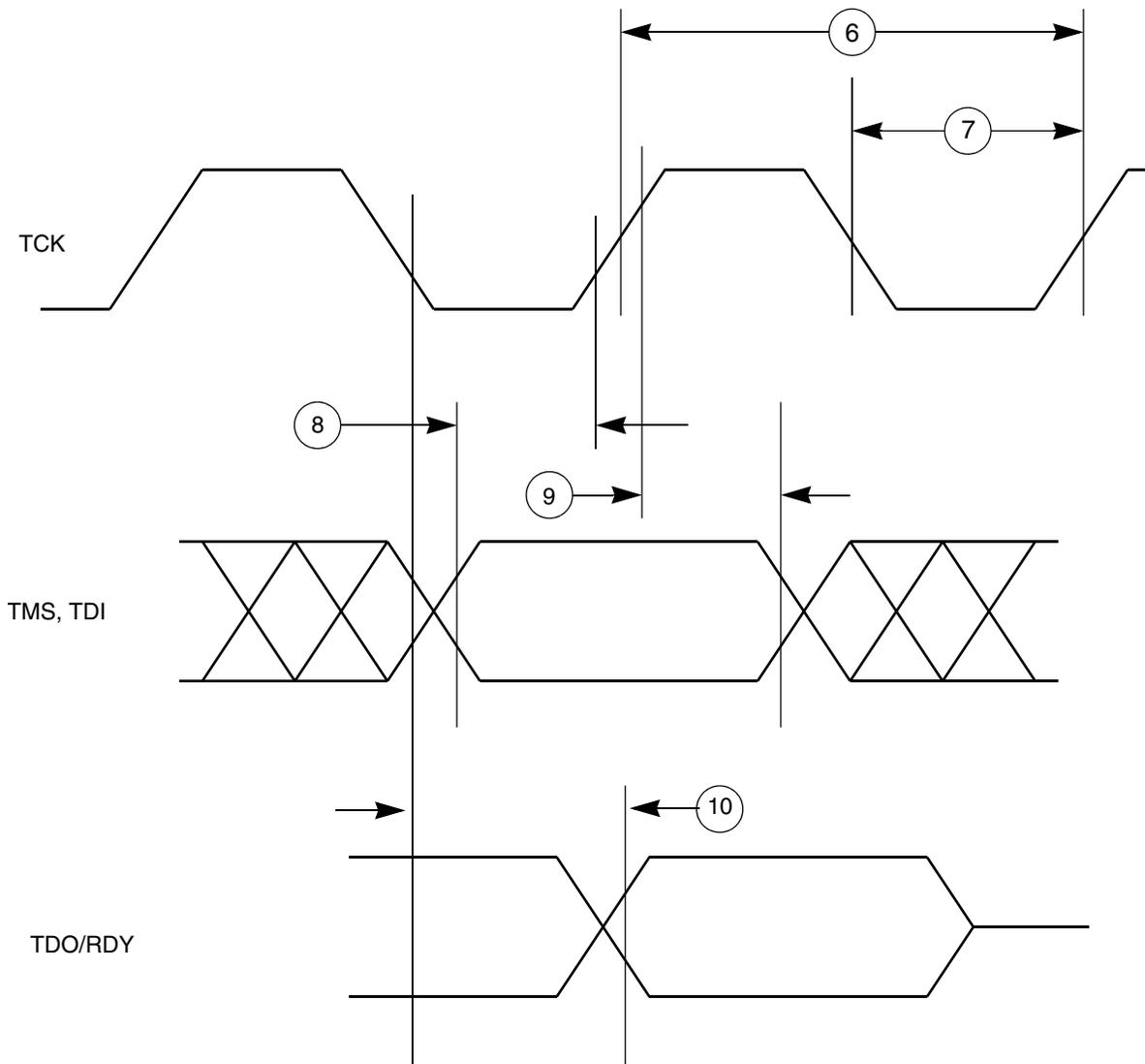


Figure 30. Nexus TDI, TMS, TDO timing

6.5.3 WKPU/NMI timing

Table 47. WKPU/NMI glitch filter

No.	Symbol	Parameter	Min	Typ	Max	Unit
1	W_{FNMI}	NMI pulse width that is rejected	—	—	20	ns
2	$W_{NFNMI}D$	NMI pulse width that is passed	400	—	—	ns

6.5.4 External interrupt timing (IRQ pin)

Table 48. External interrupt timing specifications

No.	Symbol	Parameter	Conditions	Min	Max	Unit
1	t_{IPWL}	IRQ pulse width low	—	3	—	t_{CYC}
2	t_{IPWH}	IRQ pulse width high	—	3	—	t_{CYC}
3	t_{ICYC}	IRQ edge to edge time	—	6	—	t_{CYC}

These values applies when IRQ pins are configured for rising edge or falling edge events, but not both.

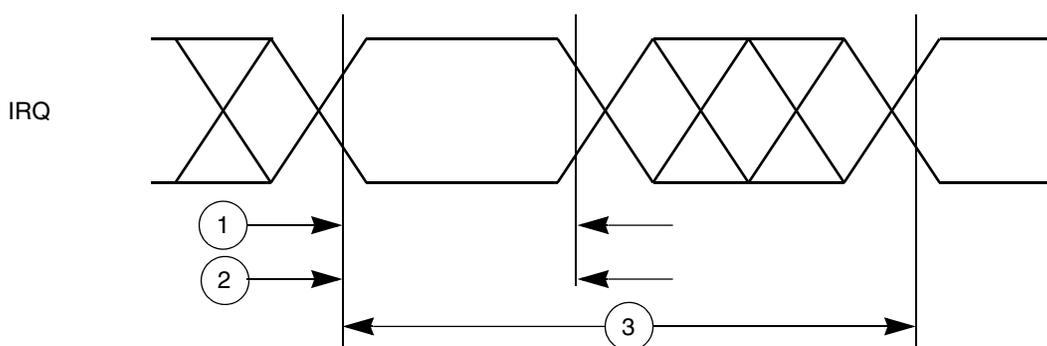


Figure 31. External interrupt timing

7 Thermal attributes

7.1 Thermal attributes

Board type	Symbol	Description	176LQFP	Unit	Notes
Single-layer (1s)	$R_{\theta JA}$	Thermal resistance, junction to ambient (natural convection)	50.7	$^{\circ}C/W$	11, 22
Four-layer (2s2p)	$R_{\theta JA}$	Thermal resistance, junction to ambient (natural convection)	24.2	$^{\circ}C/W$	1, 2, 33
Single-layer (1s)	$R_{\theta JMA}$	Thermal resistance, junction to ambient (200 ft./min. air speed)	38.1	$^{\circ}C/W$	1, 3

Table continues on the next page...

Table 51. Revision History (continued)

Rev. No.	Date	Substantial Changes
Rev 3	2 March 2016	<ul style="list-style-type: none"> • In section, Recommended operating conditions <ul style="list-style-type: none"> • Added a new Note • In section, Voltage regulator electrical characteristics <ul style="list-style-type: none"> • In table, Voltage regulator electrical specifications: <ul style="list-style-type: none"> • Added a new row for C_{HV_VDD_B} • Added a footnote on V_{DD_HV_BALLAST} • Added a new Note at the end of this section • In section, Voltage monitor electrical characteristics <ul style="list-style-type: none"> • In table, Voltage monitor electrical characteristics: <ul style="list-style-type: none"> • Removed "V_{LVD_FLASH}" and "V_{LVD_FLASH} during low power mode using LPBG as reference" rows • Updated Fall and Rise trimmed Minimum values for V_{HVD_LV_cold} • In section, Supply current characteristics <ul style="list-style-type: none"> • In table, Current consumption characteristics: <ul style="list-style-type: none"> • Updated the footnote mentioned in the Condition column of I_{DD_STOP} row • Updated all TBD values • In table, Low Power Unit (LPU) Current consumption characteristics: <ul style="list-style-type: none"> • Updated the typical value of LPU_STOP to 0.18 mA • Updated all TBD values • In table, STANDBY Current consumption characteristics: <ul style="list-style-type: none"> • Updated all TBD values • In section, AC specifications @ 3.3 V Range <ul style="list-style-type: none"> • In table, Functional Pad AC Specifications @ 3.3 V Range: <ul style="list-style-type: none"> • Updated Rise/Fall Edge values • In section, DC electrical specifications @ 3.3V Range <ul style="list-style-type: none"> • In table, DC electrical specifications @ 3.3V Range: <ul style="list-style-type: none"> • Updated Max value for Vol to 0.1 * VDD_HV_x • In section, AC specifications @ 5 V Range <ul style="list-style-type: none"> • In table, Functional Pad AC Specifications @ 5 V Range: <ul style="list-style-type: none"> • Updated Rise/Fall Edge values • In section, DC electrical specifications @ 5 V Range <ul style="list-style-type: none"> • In table, DC electrical specifications @ 5 V Range: <ul style="list-style-type: none"> • Updated Min and Max values for Pull_Ioh and Pull_Iol rows • Updated Max value for Vol to 0.1 * VDD_HV_x • In section, Reset pad electrical characteristics <ul style="list-style-type: none"> • In table, Functional reset pad electrical specifications: <ul style="list-style-type: none"> • Updated parameter column for V_{IH}, V_{IL} and V_{HYS} rows • Updated Min and Max values for V_{IH} and V_{IL} rows • In section, PORST electrical specifications <ul style="list-style-type: none"> • In table, PORST electrical specifications: <ul style="list-style-type: none"> • Updated Unit and Min/Max values for V_{IH} and V_{IL} rows • In section, Input equivalent circuit and ADC conversion characteristics <ul style="list-style-type: none"> • In table, ADC conversion characteristics (for 12-bit): <ul style="list-style-type: none"> • Updated "ADC Analog Pad (pad going to one ADC)" row • In table, ADC conversion characteristics (for 10-bit): <ul style="list-style-type: none"> • Updated "ADC Analog Pad (pad going to one ADC)" row • In section, Analog Comparator (CMP) electrical specifications <ul style="list-style-type: none"> • In table, Comparator and 6-bit DAC electrical specifications: <ul style="list-style-type: none"> • Updated Min and Max values for V_{AO} to +47 mV • Updated Max Value for t_{DLS} to 21 μs
74		<ul style="list-style-type: none"> • In section, Main oscillator electrical characteristics <ul style="list-style-type: none"> • In table, Main oscillator electrical characteristics: